

DATA SHEET

Model : SNDHS100A12

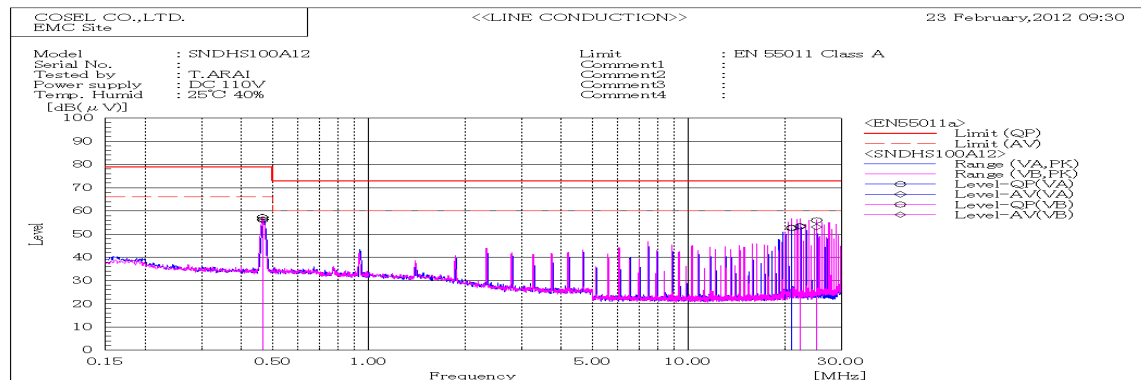
Date : 19-Apr-12

Test : EMI
Line conduction & Radiated emission

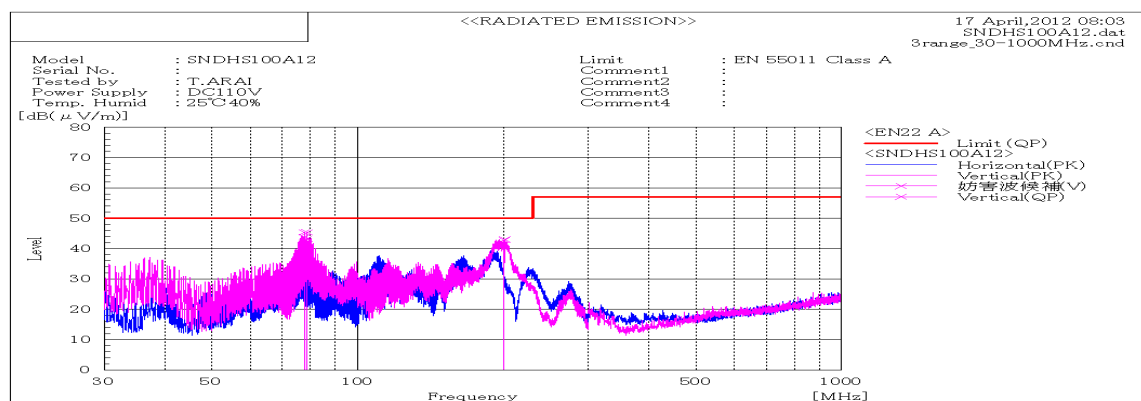
Temp. : 25 degreeC

Humid. : 40 %RH

Tested by : T.ARAI



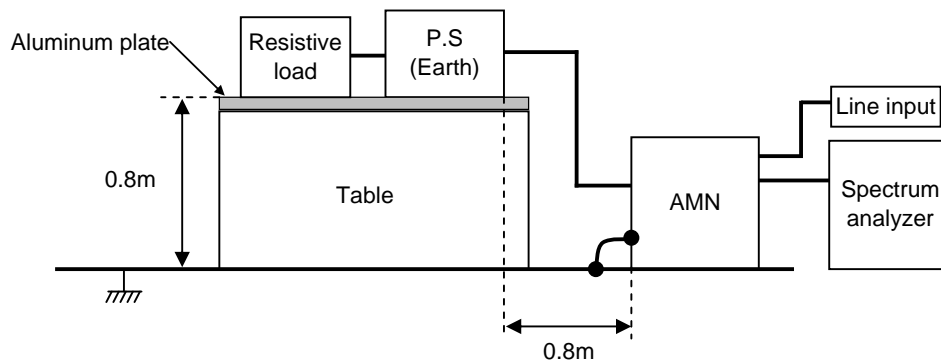
Frequency MHz	Ham	Line Phase	Reading dB(μV)		Factor dB	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/ Fail	Remark
			QP	AV		QP	AV	QP	AV	QP	AV		
0.46597		VA	46	46.2	10.1	56.1	56.3	79	66	22.9	9.7	Pass	
0.46521		VB	47.1	47.3	10.1	57.2	57.4	79	66	21.8	8.6	Pass	
20.9905		VA	41.7	41.7	11	52.7	52.7	73	60	20.3	7.3	Pass	
22.32855		VB	42.5	42.5	10.9	53.4	53.4	73	60	19.6	6.6	Pass	
25.1313		VB	44.9	42.1	11	55.9	53.1	73	60	17.1	6.9	Pass	



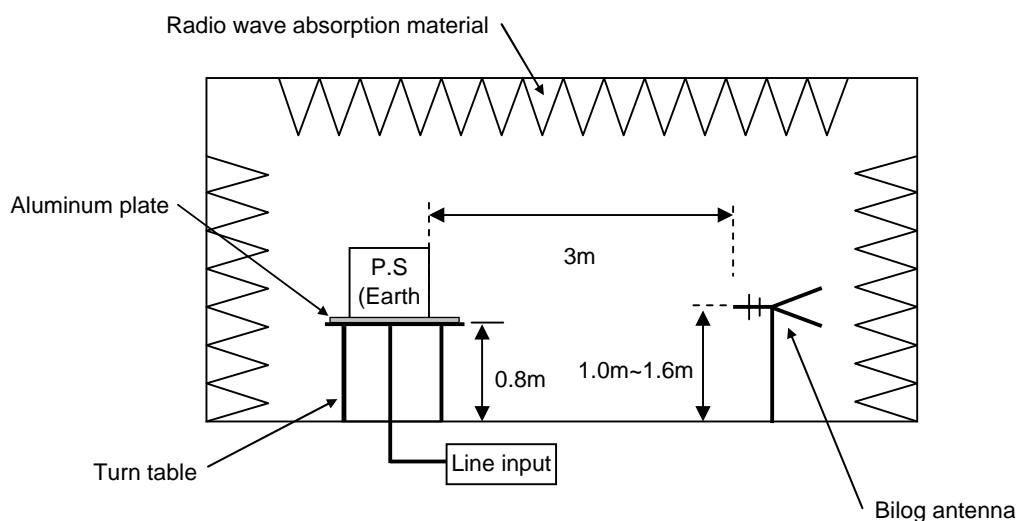
Frequency MHz	Ham	Polariz ation	Level Check	Stabili ty	Reading dB(μV)			Factor dB(1/m)	Level dB(μV/m)			Limit dB(μV/m)	Limit dB(μV/m)	Limit dB(μV/m)	Margin dB			Pass/ Fail	Height cm	Angle deg	Remark
					QP	AV	PK		QP	AV	PK				QP	AV	PK				
77.657		V		Stable	60.1			-16.3	43.8			50			6.2			Pass	104	1	
78.537		V		Stable	59.4			-16.2	43.2			50			6.8			Pass	107	26	
200.672		V		Stable	53.6			-10.9	42.7			50			7.3			Pass	106	105	

DATA SHEET		Date	19-Apr-12
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.ARAI

1. Line conduction



2. Radiated emission

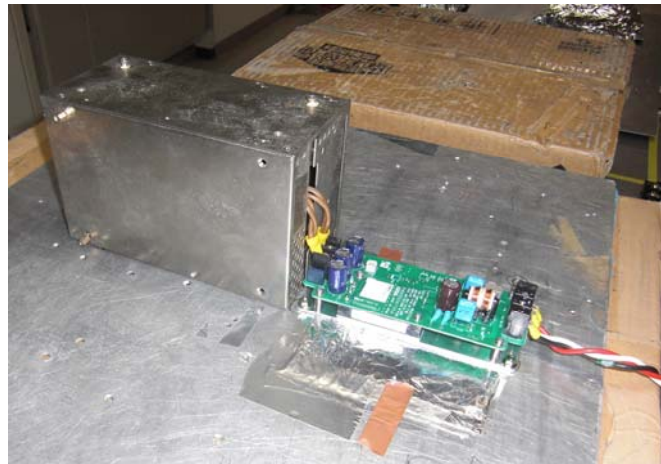


Test: EMI

Model Name: SNDHS50A/100A Series

○ Photographs of Test Set-Up

LINE CONDUCTION



RADIATED EMISSION

